## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Tapesh YADAV

Title: HIGH VOLUME MANUFACTURING OF

NANOPARTICLES AND NANO-

DISPERSED PARTICLES AT LOW COST

Appl. No.: 10/698,564

Filing Date: 10/31/2003

Examiner: Elena Tsov

Art Unit: 1762

Conf. No.: 1121

## INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR §1.56

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Submitted herewith on Form PTO/SB/08 is a listing of the documents cited by or submitted to the U.S. PTO in related applications identified below:

This application is a Division of 10/004,387 12-04-2001 Patented 6,652,967, which Claims Priority from Provisional Application 60/310,967 08-08-2001 Expired, which is a Continuation-in-part of 09/790,036 02-20-2001 Patented 6,933,331, which is a Division of 09/083,893 05-22-1998 Patented 6,228,904, which is a Continuation-in-part of 08/739,257 10-30-1996 Patented 5,905,000, which is a Continuation-in-part of 08/730,661 10-11-1996 Patented 5,952,040, which is a Continuation-in-part of 08/707,341 09-03-1996 Patented 5,788,738.

As provided in 37 CFR §1.98(d), copies of the documents are not being provided since they were previously submitted to the United States Patent & Trademark Office in one of the above-identified applications.

The submission of any document herewith, which is not a statutory bar, is not intended as an admission that such document constitutes prior art against the claims of the present application or that such document is considered material to patentability as defined in 37 CFR §1.56(b). Applicant does not waive any rights to take any action which would be appropriate to antedate or otherwise remove as a competent reference any document which is determined to be a *prima facie* art reference against the claims of the present application.

## TIMING OF THE DISCLOSURE

The listed documents are being submitted in compliance with 37 CFR §1.97(c), before the mailing date of either a final action under 37 CFR §1.113, a notice of allowance under 37 CFR §1.311, or an action that otherwise closes prosecution in the application.

Applicant respectfully requests that each listed document be considered by the Examiner and be made of record in the present application and that an initialed copy of Form PTO/SB/08 be returned in accordance with MPEP §609.

## FEE

Fees in the amount of \$180.00 in accordance with 37 CFR §1.17(p) to cover the fee associated with an information disclosure statement under 37 CFR §1.97(c) are being paid by credit card via EFS-Web.

The Commissioner is hereby authorized to charge any additional fees which may be required regarding this application under 37 C.F.R. §§ 1.16-1.17, or credit any overpayment, to Deposit Account No. 19-0741.

Respectfully submitted,

Date July 18, 2007

FOLEY & LARDNER LLP Customer Number: 22428 Telephone: (202) 672-5569

Facsimile: (202) 672-5399

By A

Stephen B. Maebius Attorney for Applicant Registration No. 35,264

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number. Substitute for form 1449/PTO Complete if Known INFORMATION DISCLOSURE Application Number 10/698.564 STATEMENT BY APPLICANT 10/31/2003 Filing Date First Named Inventor Tapesh Yaday Date Submitted: July 18, 2007 Art Unit 1762 (use as many sheets as necessary) Examiner Name Elena Tsoy 037768-0173 Sheet 1 of 11 Attorney Docket Number

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Examiner Initials*	Cite No.1	Document Number  Number-Kind Code <sup>2</sup> (#known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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	Substitute	for form 1449/PTO		Complete if Known		
	INFORMAT	ON DISCLOSURE	Application Number	10/698,564		
	STATEMEN	T BY APPLICANT	Filing Date	10/31/2003		
	Data Submi	tted: July 18, 2007	First Named Inventor	Tapesh Yadav		
	Date Subini	ileu. July 10, 2007	Art Unit	1762		
	(use as many	sheets as necessary)	Examiner Name	Elena Tsoy		
Sheet	2	of 11	Attorney Docket Number	037768-0173		

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Examiner	Date	
Signature	Considered	

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	Substitute for t	form 1449/I	PTO	Complete if Known		
	INFORMATION	DISCLO	SURE	Application Number	10/698,564	
STATEMENT BY APPLICANT  Date Submitted: July 18, 2007				Filing Date	10/31/2003	
				First Named Inventor	Tapesh Yadav	
	Date Submitted	a. July 10,	2007	Art Unit	1762	
(use as many sheets as necessary)				Examiner Name	Elena Tsoy	
Sheet	3	of	11	Attorney Docket Number	037768-0173	

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Examiner Signature	Date Considered	
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\*EXAMINER. Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered Include copy of this form with next communication to applicant. 1 Applicant's unique citation designation number (optional). 2 See Kinds Codes of USPTO Patent Documents at www uspto gov or MPEP 901.04 3 Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). 4 For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. 5 Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. 6 Applicant is to place a check mark here if English language Translation is attached This collection of information is required by 37 CFR 1.97 and 1.98. The information is required to obtain or retain a benefit by the public which is to file (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.14. This collection is estimated to take 2 hours to complete, including gathering, preparing, and submitting the completed application form to the USPTO. Time will vary depending upon the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this burden, should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, P.O. Box 1450, Alexandria, VA 22313-1450, DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS, SEND TO: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450

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	Substitute for	or form 1449/	PTO	Complete if Known		
	INFORMATION	ON DISCLO	SURE	Application Number	10/698,564	
	STATEMEN'	T BY APPL	ICANT	Filing Date	10/31/2003	
	Date Submit	tod: July 19	2007	First Named Inventor	Tapesh Yadav	
	Date Submit	iteu. July 10	, 2007	Art Unit	1762	
	(use as many s	sheets as ne	cessary)	Examiner Name	Elena Tsoy	
Sheet	4	of	11	Attorney Docket Number	037768-0173	

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		U.S. PATENT	DOCUMENTS	
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Examiner Signature		Date Considered	
*EXAMINER Initi	al if reference considered, whether or not citation is in conformance with MPEP 609. Dra	w line through citation if not in	conformance and not considered

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	INFORMATION	ON DISCLO	SURE	Application Number	10/698,564		
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				First Named Inventor	Tapesh Yadav	-	
				Art Unit	1762		
				Examiner Name	Elena Tsoy		
Sheet	5	of	11	Attorney Docket Number	037768-0173		

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Examiner Signature		Date Considered	
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				Application Number	10/698,564		
STATEMENT BY APPLICANT Date Submitted: July 18, 2007			CANT	Filing Date	10/31/2003		
			2007	First Named Inventor	Tapesh Yadav		
	Date Gubilitted. 5	uly 10,	2007	Art Unit	1762		
	(use as many sheets	as ne	cessary)	Examiner Name	Elena Tsoy		
Sheet	6	of	11	Attorney Docket Number	037768-0173		

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	Date Subili	tied. July 10,	2007	Art Unit	1762		
	(use as many	sheets as nec	essary)	Examiner Name	Elena Tsoy		
Sheet	7	of	11	Attorney Docket Number	037768-0173		

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			First Named Inventor	Tapesh Yadav	
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(use as many sheets as necessary)			Examiner Name	Elena Tsoy	
Sheet 8	of	11	Attorney Docket Number	037768-0173	

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	INFORMATION DIS	SCLO	SURE	Application Number	10/698,564	
	STATEMENT BY A	APPLI	CANT	Filing Date	10/31/2003	
	Date Submitted: Ju	du 10	2007	First Named Inventor	Tapesh Yadav	
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	(use as many sheets	as ne	cessary)	Examiner Name	Elena Tsoy	
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